

<b>Notice of References Cited</b>	Application/Control No. 10/705,347	Applicant(s)/Patent Under Reexamination LABELLE ET AL.	
	Examiner Kin-Chan Chen	Art Unit 1765	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0188240	09-2004	Chang et al.	204/192.12
*	B	US-6,090,210	07-2000	Ballance et al.	118/725
*	C	US-6,759,337	07-2004	Aronowitz et al.	438/706
*	D	US-2005/0019964	01-2005	Chang et al.	438/016
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.